

John Nichols, 10:30 AM 10/21/02.0500, "Public Forum on Labeling"

X-Sieve: CMU Sieve 2.2
X-Sender: nicholsj@neo.tamu.edu
X-Mailer: QUALCOMM Windows Eudora Version 5.1.1
Date: Mon, 21 Oct 2002 10:30:24 -0500
To: james.mccracken@nist.gov
From: John Nichols <nicholsj@tamu.edu>
Subject: "Public Forum on Labeling"
Cc: metric-prg@nist.gov

Dear Sir,

I have found a flyer for the public forum on labeling. I would like to attend the forum but I am in Texas teaching on the 7 November 2002.

I would support the adoption of single metric labels. The waste of time and energy I put into teaching both systems is a drain on the educational time of these students. We are merely delaying the inevitable as the USA is slowly going metric with the construction industry one of the last hold outs.

I would add my voice to the request for metric only labels. The argument that the other is required for comparison is illusionary. As long as there is a system to compare ratios of cost ie cents/ ml etc the US public will be able to discern value.

John Nichols

John Nichols BE, Ph.D. Professional Engineer
Assistant Professor
Texas A&M University
Department of Construction Science
Langford AC
Rm: A414 MD 3137
College Station, TX 77843-3137

Electronic mail: nicholsj@tamu.edu
Telephone: 979 845 6541
Facsimile: 979 862 1572

Magna res est vocis et silentii temperamentum

The greatest thing is to know when to speak
and when to keep quiet
Seneca the Younger (attributed)

Printed for Jim McCracken <james.mccracken@nisl.gov> 1